

<b>Notice of References Cited</b>	Application/Control No. 10/553,259		Applicant(s)/Patent Under Reexamination SCHNEIDER, EWALD	
	Examiner ATNAF ADMASU		Art Unit 4171	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,071,924 A	12-1991	Koch et al.	525/432
*	B	US-5,773,556 A	06-1998	Kleiner et al.	528/321
*	C	US-6,255,371 B1	07-2001	Schlosser et al.	524/100
*	D	US-6,319,986 B1	11-2001	Amimoto et al.	525/66
*	E	US-6,547,992 B1	04-2003	Schlosser et al.	252/609
*	F	US-2005/0049339 A1	03-2005	Knop et al.	524/115
*	G	US-2005/0101708 A1	05-2005	Knop et al.	524/115
*	H	US-2006/0138391 A1	06-2006	Drewes et al.	252/601
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.